## WEST

## Freeform Search

	US Patents Full-Text Database US Pre-Grant Publication Full-Text Database JPO Abstracts Database EPO Abstracts Database Derwent World Patents Index IBM Technical Disclosure Bulletins	Database	
	12 and microelectromechanical	Term:	
er [1]	Display Format: CIT Storting with M	Display: Generate:	
	Search Clear Help Logout Interrupt  Main Menu Show S Numbers Edit S Numbers Preferences		
er <u>1</u>	10 Documents in Display Format: CIT Starting with Number e: O Hit List O Hit Count O Image  Search Clear Help Logout Interrupt		

## Search History

Today's Date: 7/31/2001

<u>DB Name</u> USPT USPT USPT	Query 15 and microelectromechanical 14 and microelectromechanical 12 and microelectromechanical	Hit Count 0 3	<u>Set Name</u> <u>L9</u> <u>L8</u>
JPAB,EPAB,DWPI	photoresist and (etch\$ or pattern) and oxide and mask\$ and (micromechanical)	9	<u>L7</u> <u>L6</u>
JPAB,EPAB,DWPI USPT	photoresist and (etch\$ or pattern) and oxide and mask\$ (((438/723  438/734  438/736  438/743  438/753  438/756  438/942 )!.CCLS.) ) and photoresist and etch\$ and oxide	3019	<u>L5</u>
USPT	((438/723  438/734  -138   736  438/743  438/753  438/756  438/942 )!.CCLS. )	528 1279	<u>L4</u> <u>L3</u>
	((216/41  216/47  216/79  216/80  216/97  216/99 )! CCLS.) ) and photoresist and etch\$ and oxide and mask\$ (216/41  216/47  216/79  216/80  216/97  216/99 )! CCLS.)	475	<u>L2</u>
	[516/57]:.CCES. )	2323	<u>L1</u>